Application/Control No. Applicant(s)/Patent Under Reexamination 10/743,803 LEE, YOUNG SIN Notice of References Cited Examiner Art Unit Page 1 of 1 Ben H. Liu 2609 **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY US-6,519,249 02-2003 Bennefeld et al. 370/352 US-6,374,302 04-2002 Galasso et al. 709/238 В US-2003/0035414 02-2003 Beyda, William J. 370/352 С US-6,868,059 03-2005 Jones et al. 370/216 D 370/352 05-2001 Mortsolf et al. US-6,229,804 Ε 370/218 08-2004 Korpi et al. F US-6,785,223 US-G US-Н US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS**

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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